

B/O Form PTO-1449  U.S. Department of Commerce Patent and Trademark Office  Information Disclosure Statement by Applicant	Atty. Docket Number	Serial Number
	CHEN3585/EM	Unassigned
	Applicant	
	Sinn-Wen CHEN	
	Filing Date	Group
	Concurrently Herewith - Sept. 9, 2003	

## U.S. Patent Documents

Examiner Initial	Document Number	Date	Patentee/Applicant	Class	Subclass	Filing Date if Appropriate

## Foreign Patent Documents

Examiner Initial	Document Number	Publication Date	Country/Agency	Class	Subclass	Translation	
						Yes	No

## Other Documents (Including Author, Title, Date, Pertinent Pages, Place of Publication, Etc.)

/J.S./	H. B. Huntington, <i>Electromigration in Metals in Diffusion In Solids: Recent Developments</i> , pp. 303-353, edited by Nowick and Burton, Academic Press, New York, 1975.
/J.S./	M. Y. Hsieh et. al., <i>Electromigration of Copper in Lead</i> , J. Phys. Chem. Solids, Vol. 39, pp. 867-871, 1978
/J.S./	C. K. Hu et. al., <i>Diffusion and electromigration of silver and nickel in lead-tin alloys</i> , Physical Review, Vol. 26, No. 6, pp. 2782-2789, 1982

Examiner	/John Sheehan/	Date Considered	06/06/2007
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